

Notice of References Cited	Application/Control No. 10/743,101	Applicant(s)/Patent Under Reexamination OONISHI ET AL.	
	Examiner Gary Chin	Art Unit 3661	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,415,226	07-2002	Kozak, Frank J.	701/210
	B	US-6,363,319	03-2002	Hsu, Ivy P.	701/202
	C	US-2002/0103599 A1	08-2002	Sugiyama et al.	701/211
	D	US-6,256,579	07-2001	Tanimoto, Satoshi	701/201
	E	US-5,612,882	03-1997	LeFebvre et al.	701/209
	F	US-5,841,366	11-1998	Yamamoto et al.	340/901
	G	US-6,230,083	05-2001	Matsuda et al.	701/1
	H	US-6,195,611	02-2001	Sakamoto et al.	701/209
	I	US-6,134,501	10-2000	Oumi, Masanori	701/209
	J	US-2002/0082772 A1	06-2002	Okano, Hiroyuki	701/209
	K	US-6,510,384	01-2003	Okano, Hiroyuki	701/209
	L	US-6,662,101	12-2003	Adachi, Shinya	701/201
	M	US-5,043,902	08-1991	Yokoyama et al.	701/211

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.